

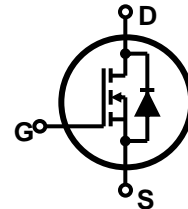
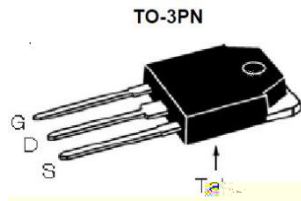
TMAN20N50

N-channel MOSFET

Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- JEDEC Qualification

BV_{DSS}	I_D	$R_{DS(on)}$
500V	20A	<0.3 Ω



Device	Package	Marking	Remark
TMAN20N50	TO-3PN	TMAN20N50	RoHS

Absolute Maximum Ratings

Parameter	Symbol	TMAN20N50	Unit	
Drain-Source Voltage	V_{DS}	500	V	
Gate-Source Voltage	V_{GS}	30	V	
Continuous Drain Current	I_D	$T_C = 25$	20	A
		$T_C = 100$	13.1	A
Pulsed Drain Current (Note 1)	I_{DM}	80	A	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	1088	mJ	
Repetitive Avalanche Current (Note 1)	I_{AR}	20	A	
Repetitive Avalanche Energy (Note 1)	E_{AR}	31.2	mJ	
Power Dissipation	P_D	$T_C = 25$	312	W
		Derate above 25	2.5	W/
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150		
Maximum lead temperature for soldering purposes,	T_L	300		

* Limited only by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	TMAN20N50	Unit
Maximum Thermal resistance, Junction-to-Case	$R_{\theta JC}$	0.4	/W
Maximum Thermal resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	/W

Electrical Characteristics : $T_C=25$, unless otherwise noted

Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	500	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 500\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	μA
		$V_{DS} = 400\text{ V}, T_C = 125^\circ\text{C}$	--	--	10	μA
Forward Gate-Source Leakage Current	I_{GSSF}	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

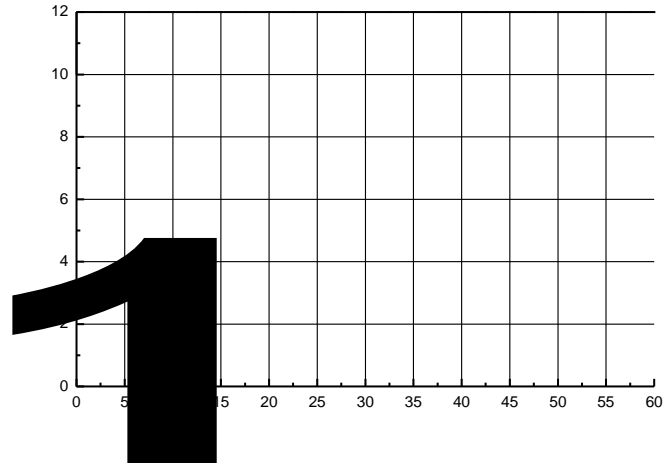
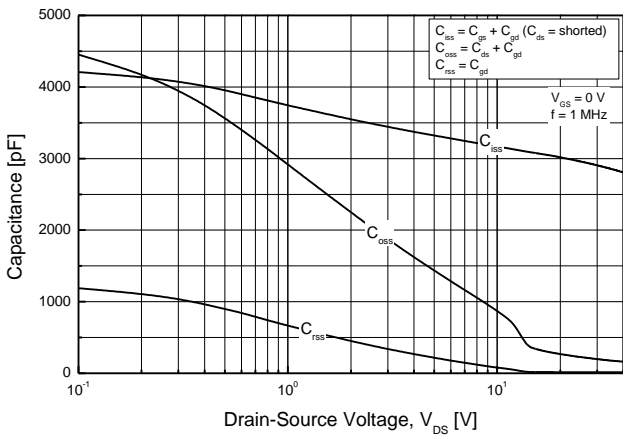
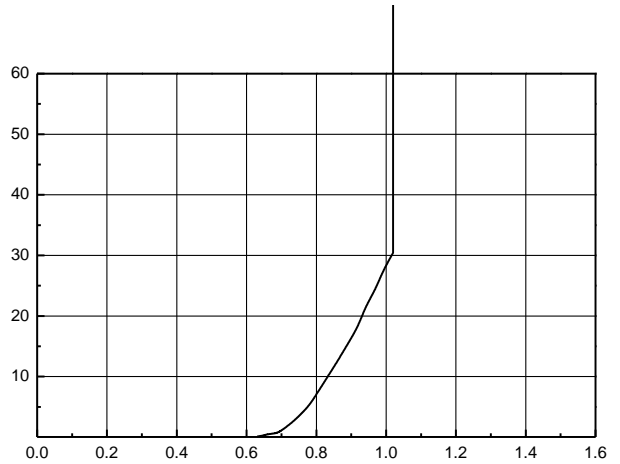
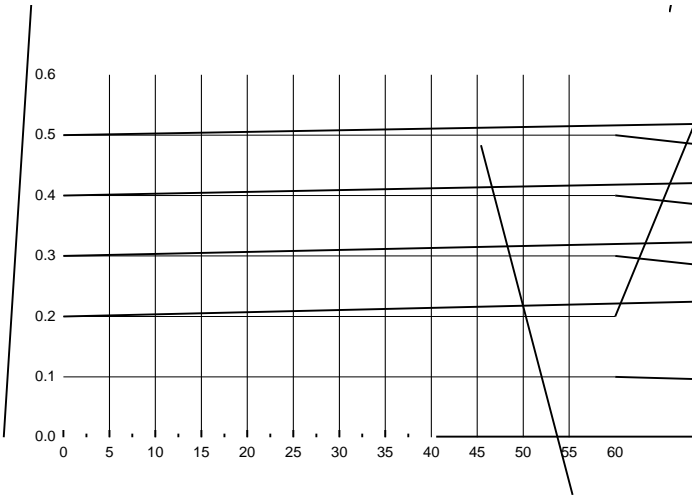
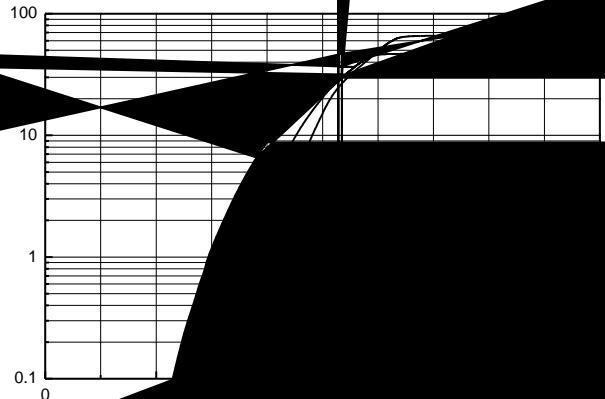
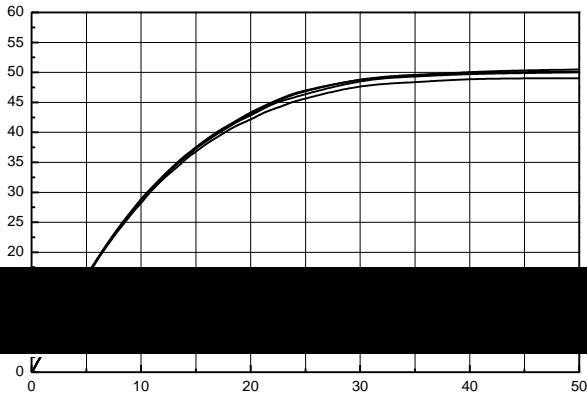
ON						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 10\text{ A}$	--	0.25 1	0.3	Ω 0
Forward Transconductance (Note 4)	g_{FS}	$V_{DS} = 30\text{ V}, I_D = 10\text{ A}$	--	11	--	S

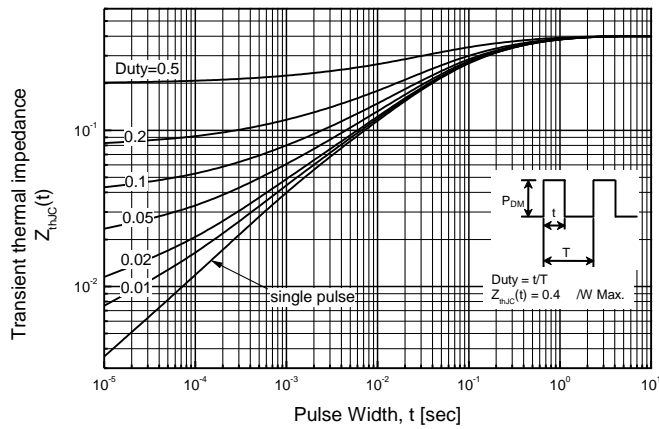
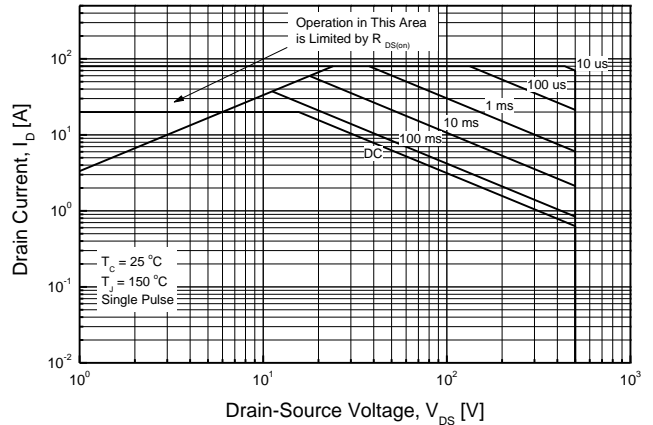
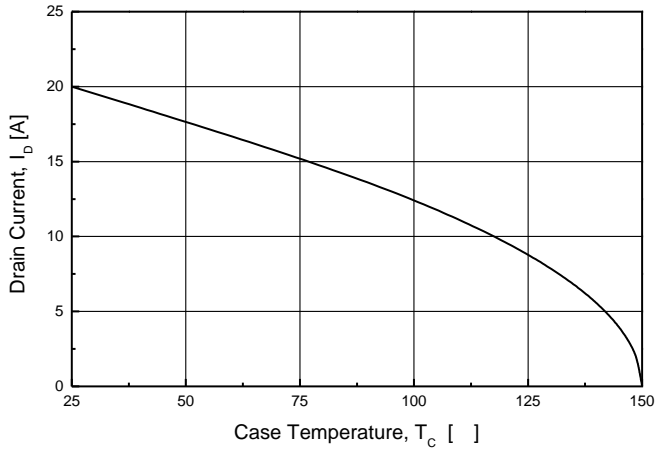
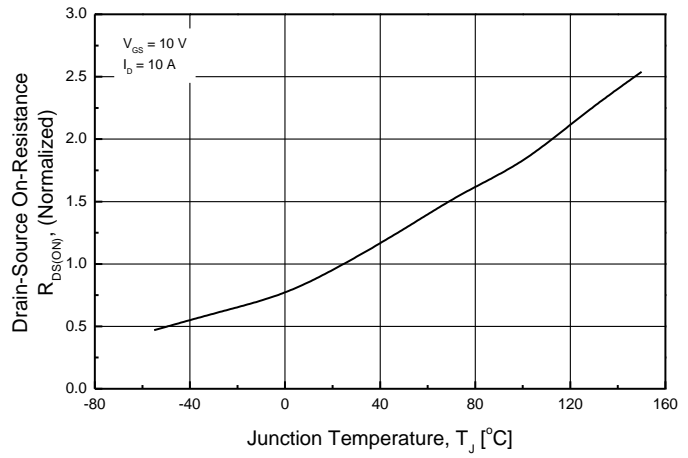
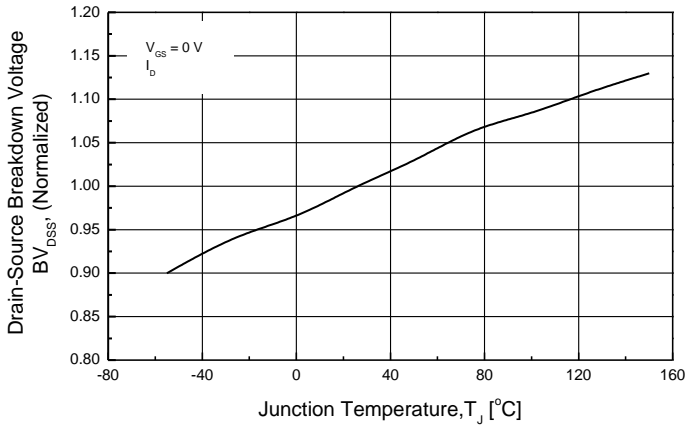
DYNAMIC						
Input Capacitance	C_{iss}	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	3094	--	pF
Output Capacitance	C_{oss}		--	296	--	pF
Reverse Transfer Capacitance	C_{rss}		1	1 --	9.2	--

SWITCHING						
Turn-On Delay Time (Note 4,5)	$t_{d(on)}$	$V_{DD} = 250\text{ V}, I_D = 20\text{ A},$ $R_G = 25$	--	78	--	ns
Turn-On Rise Time (Note 4,5)	t_r		--	72	--	ns
Turn-Off Delay Time (Note 4,5)	$t_{d(off)}$		--	184	--	ns
Turn-Off Fall Time (Note 4,5)	t_f		--	68	--	ns
Total Gate Charge (Note 4,5)	Q_g	$V_{DS} = 400\text{ V}, I_D = 20\text{ A},$ $V_{GS} = 10\text{ V}$	--	54	--	nC
Gate-Source Charge (Note 4,5)	Q_{gs}		--	8 15	--	1 nC
Gate-Drain Charge (Note 4,5)	Q_{gd}		--	12.5	--	nC

SOURCE DRAIN DIODE						
Maximum Continuous Drain-Source						

- Note :
1. Repeated rating : Pulse width limited by safe operating area
 2. $L=4.9\text{mH}, I_{AS} = 20\text{A}, V_{DD} = 50\text{V}, R_G = 25$, Starting $T_j = 25$
 3. I_{SD} $\mu\text{s}, V_{DD}$ $\mu\text{s}, V_{DS}$ μs , Starting $T_j = 25$
 5. Essentially Independent of Operating Temperature Typical Characteristics







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